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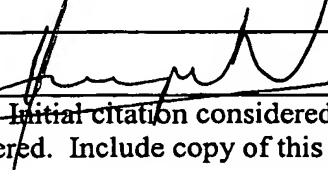
Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty Docket No.	EVLDP001
	Application No.:	10/041,768
	Applicant	Miller et al.
	Filing Date	10/31/01
	Group	2179

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	A.						
	B.						

Other Documents

Examiner Initial	No.	Author, Title, Place (e.g. Journal) of Publication, Date
HB	C.	The Third International Software Quality Week Europe 1999: Lessons Learned, Seminar/Conference outline, Brussels, Belgium, November 1-5, 1999.
	D.	The Thirteenth International Software & Internet Quality Week, Registration Materials for Seminar/Conference, San Francisco, CA, May 30-June 2, 2000.
	E.	"Testing Techniques Newsletter (TTN)," On-line edition, July 1999, pp. 1-18.
	F.	Edward Miller, "WebSite Testing," White paper, 2000 (printed on October 31, 2000).
	G.	Edward Miller, "WebSite Testing," White paper, presented at the Third International Software Quality Week Europe 1999, Brussels, Belgium, November 1-5, 1999.
	H.	Software Tech News, "WebSite Testing-Software Testing," Vol. 3, No. 2, printed from http://dacs.dtic.mil/awareness/newsletters/stn3-2/toc.html on October 31, 2000.
	I.	eValid, "Subscription Test TeleServices, Custom Website Testing and Validation, Web Site Quality Consulting," presented at the Third International Software Quality Week Europe 1999, Brussels, Belgium, November 1-5, 1999.
	J.	eValid, "E-Commerce Reliability and Web Site Testing," (with attached video graphics), presented at the Third International Software Quality Week Europe 1999, Brussels, Belgium, November 1-5, 1999.
	K.	"First Browser Based Web Testing Tool Provides Accuracy Breakthrough," Press Release, eValid, Inc., September 6, 2000.
	L.	Product Release Notes, CAPBAK/Web [IE] Ver. 1.5, November 24, 1999.
HB	M.	Product Release Notes, CAPBAK/Web [IE] for Windows NT and Windows 2000, March 21, 2000.

Examiner 	Date Considered 12/23/05
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.